# **Power MOSFET**

# 30 V, 1.15 m $\Omega$ , 241 A, Single N–Channel Logic Level, SO–8FL

### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS4C302NWF Wettable Flanks Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V <sub>DSS</sub>	30	V	
Gate-to-Source Voltage	Э		$V_{GS}$	±20	V
Continuous Drain Current $R_{\theta JC}$ (Notes 1, 2, 3)	Steady State	T <sub>C</sub> = 25°C	Ι <sub>D</sub>	241	Α
Power Dissipation R <sub>θJC</sub> (Notes 1, 2)	Olale	$T_C = 25^{\circ}C$	P <sub>D</sub>	115	W
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2, 3)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	43	А
Power Dissipation R <sub>θJA</sub> (Notes 1, 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.75	W
Pulsed Drain Current	Pulsed Drain Current $T_A = 25^{\circ}C$ , $t_p = 10 \mu s$			900	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body Diode)			I <sub>S</sub>	153	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 61 A)		E <sub>AS</sub>	186	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	1.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	40	

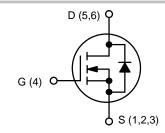
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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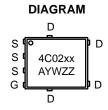
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	1.15 mΩ @ 10 V	044.4
30 V	1.7 mΩ @ 4.5 V	241 A



**N-CHANNEL MOSFET** 



STYLE 1



**MARKING** 

4C02N = Specific Device Code for NVMFS4C302N

4C02WF= Specific Device Code of

NVMFS4C302NWF

A = Assembly Location

Y = Year W = Work Week ZZ = Lot Traceability

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVMFS4C302NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NVMFS4C302NWFT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS							•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				24		mV/°C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25 °C			1.0	μА	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			100		
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA	
ON CHARACTERISTICS (Note 4)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.3		2.2	V	
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.8		mV/°C	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		0.95	1.15	+	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		1.35	1.7	mΩ	
Forward Transconductance	9FS	$V_{DS} = 3 \text{ V}, I_{D}$	= 30 A		135		S	
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25	°C		1.0		Ω	
CHARGES AND CAPACITANCES	•			•	•		•	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			5780		pF	
Output Capacitance	C <sub>OSS</sub>				2320			
Reverse Transfer Capacitance	C <sub>RSS</sub>				70			
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			37		nC	
Threshold Gate Charge	Q <sub>G(TH)</sub>				9.0			
Gate-to-Source Charge	Q <sub>GS</sub>				16			
Gate-to-Drain Charge	$Q_{GD}$				7.0			
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 30 \text{ A}$			82		nC	
SWITCHING CHARACTERISTICS (Note 5)							•	
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}, I_{D} = 15 \text{ A},$ $R_{G} = 3.0 \Omega$			13			
Rise Time	t <sub>r</sub>				18		1	
Turn-Off Delay Time	t <sub>d(OFF)</sub>				54		ns -	
Fall Time	t <sub>f</sub>				9.0			
DRAIN-SOURCE DIODE CHARACTERISTIC	s						•	
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V.	T <sub>J</sub> = 25°C		0.75	1.1	V	
		$V_{GS} = 0 V,$ $I_{S} = 10 A$	T <sub>J</sub> = 125°C		0.6			
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dI}_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 30 \text{ A}$			56			
Charge Time	ta				29		ns	
Discharge Time	t <sub>b</sub>				27		1	
Reverse Recovery Charge	Q <sub>RR</sub>				69		nC	

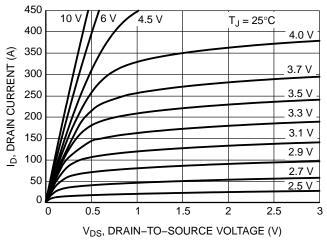
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**

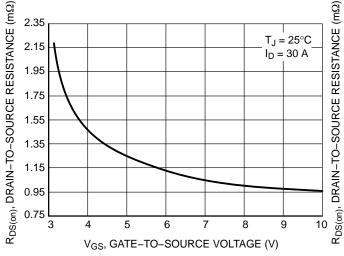
450



 $V_{DS} = 3 V$ 400 350 D, DRAIN CURRENT (A) 300 250 200 150  $T_J = 125^{\circ}C$ 100  $T_J = 25^{\circ}C$ 50  $T_J = -55^{\circ}C$ 1.5 2.0 2.5 3.0 3.5 4.5 VGS, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



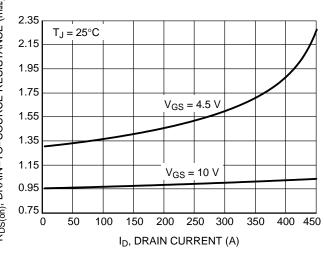
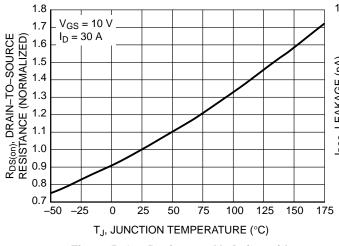


Figure 3. On-Resistance vs. V<sub>GS</sub>

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



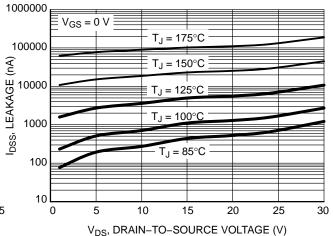
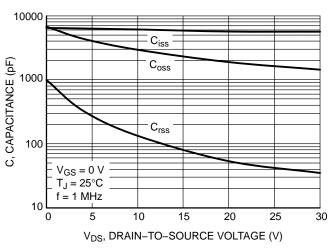


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

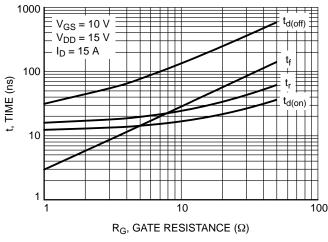
## **TYPICAL CHARACTERISTICS**



11 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)  $Q_T$ 10 9 8 7 6 5  $Q_{\underline{q}\underline{d}}$ 4  $\mathsf{Q}_{\mathsf{g}_{\underline{\mathsf{J}}}^{\mathsf{S}}}$ 3  $V_{DS} = 15 V$  $I_{D} = 30 \text{ A}$  $T_J = 25^{\circ}C$ 0 70 10 20 40 50 60 90 80 Qg, TOTAL GATE CHARGE (nC)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge



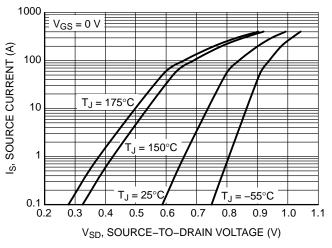


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

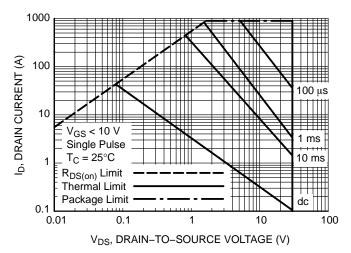


Figure 11. Maximum Rated Forward Biased Safe Operating Area

## **TYPICAL CHARACTERISTICS**

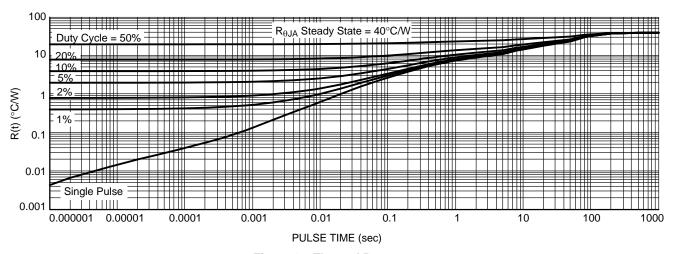


Figure 12. Thermal Response

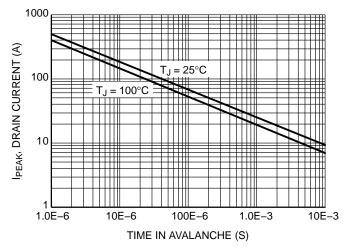


Figure 13. Maximum Drain Current vs. Time in Avalanche



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

**DATE 25 JUN 2018** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
θ	0 °		12 °		

## **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

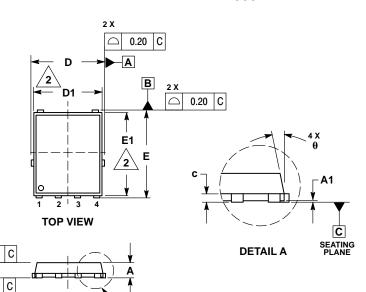
= Assembly Location Α

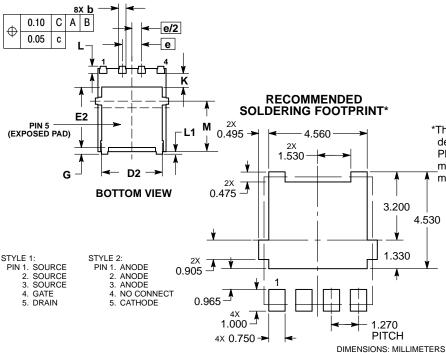
= Lot Traceability

Υ = Year W = Work Week

ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL A** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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